

PT I  
10/2/02  
M.M.

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of :  
HARUO FURUTA ET AL : GROUP ART UNIT: 2811  
Serial No: 10/014,345 : EXAMINER: OWENS, D.  
Filed: December 14, 2001 :  
For: SEMICONDUCTOR DEVICE AND  
MANUFACTURING METHOD THEREFOR

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TECHNOLOGY CENTER 2800

POWER TO INSPECT AND MAKE COPIES

Assistant Commissioner for Patents  
Washington, D.C. 20231

Dear Sir:

The undersigned hereby grants to Muralidhar Pai, or Khalid Quraishi the power to inspect the above-identified application and make copies thereof.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,  
MAIER & NEUSTADT, P.C.



Bradley D. Lytle  
Registration No. 40,073



**22850**